

**Course Schedule, group M18-621****MONDAY**

08:30 — 10:05	■ LEC	Opt	Military Training ♣ dep.20
10:15 — 16:05	■ SEM	Opt	Military Training ♣ dep.20

**TUESDAY**

08:30 — 10:05	■ PR	Academic (Research) Practice ♣ Sidorov A.V., Maksimkin A.I. ♣ VNIIA
16:15 — 17:50	■ PR	Academic (Research) Practice ♣ Sidorov A.V., Maksimkin A.I. ♣ dep.18
17:55 — 18:40	■ LEC	Reliability of Complex Technical Systems ♣ Kudryavtsev E.M. ♣ A-220
18:45 — 21:10	■ SEM	Reliability of Complex Technical Systems ♣ Kudryavtsev E.M. ♣ A-220

**WEDNESDAY**

09:20 — 10:05	■ LEC	Basic Metrology and Measurement Errors ♣ Ryabeva E.V. ♣ A-220
10:15 — 11:50	■ SEM	Basic Metrology and Measurement Errors ♣ Ryabeva E.V. ♣ A-220
11:55 — 13:30	■ LEC	Nuclear Physics ♣ Samosadnyy V.T., Boyko N.V. ♣ 406
14:30 — 16:05	■ SEM	Nuclear Physics (2018-12-12 — 2018-12-19) ♣ Samosadnyy V.T., Boyko N.V. ♣ 405
	■ SEM	Nuclear Physics (2018-09-05 — 2018-11-28) ♣ Samosadnyy V.T., Boyko N.V. ♣ 64-33
	■ SEM	Nuclear Physics (2018-09-12 — 2018-12-05) ♣ Boyko N.V., Samosadnyy V.T. ♣ 64-33
16:15 — 17:50	■ SEM	Selected Chapters of Higher Mathematics (2018-09-05 — 2018-12-05) ♣ Kutukov A.A., Sinelschikov D.I. ♣ 64-31
	■ SEM	Selected Chapters of Higher Mathematics (2018-12-12 — 2018-12-19) ♣ Kutukov A.A., Sinelschikov D.I. ♣ 98-6

**THURSDAY**

11:55 — 12:40	■ LEC	Methods Of Physical And Mathematical Modeling Of Technical Components, Units and Systems ♣ Maksimkin A.I. ♣ A-220
12:45 — 15:15	■ SEM	Methods Of Physical And Mathematical Modeling Of Technical Components, Units and Systems ♣ Maksimkin A.I. ♣ A-220
16:15 — 17:50	■ SEM	English Language (Technological Terminology) ♣ Kondratieva I.I. ♣ B-401
17:55 — 19:30	■ LAB	Computer Technology ♣ Novikov A.B. ♣ A-220

**FRIDAY**

10:15 — 11:50	■ LEC	Selected Chapters of Higher Mathematics ♣ Goryunov A.F. ♣ A-100
	■ LEC	Principles of Complex Technical Systems Design. Standardization and Systems of Quality Assurance. ♣ Erofeeva T.K., Ulyanin O.V. ♣ VNIIA
11:55 — 15:15	■ SEM	Principles of Complex Technical Systems Design. Standardization and Systems of Quality Assurance. ♣ Erofeeva T.K., Ulyanin O.V. ♣ VNIIA